

**Search Notes**

Application/Control No.

10/652,649

Examiner

Y Quach Lee

Applicant(s)/Patent under  
Reexamination

TAWIL ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362 353	Updated Search	4/28/2005	YMY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
362	Above	4/28/2005	YMY

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	4/28/2005	YMY